

# new & notable products

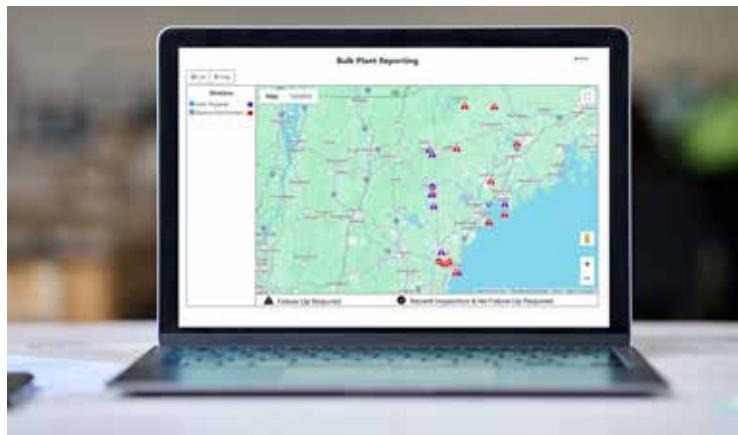


## ▲ KAMAN INC.

### AMS Family of High-Precision Non-Contact Displacement Sensors for Materials Research & Development

[kaman.com](http://kaman.com)

Kaman Inc. announced its Advanced Magnetic Sensing (AMS) family of high-precision, non-contact displacement sensors, specifically designed for the materials research and development market. These sensors are engineered to deliver high precision with root mean square resolution down to 1 micron, providing accurate measurements for research applications. This system's noncontact measurement capability is crucial for maintaining the integrity of delicate materials. Kaman's AMS sensors are well-suited for applications, such as surface finish inspection, crack and defect detection, and other measurements in materials research.



## ▲ P3 PROPANE SAFETY

### Bulk Plant Inspections & Reporting

[p3propane.com](http://p3propane.com)

Maintaining regulatory compliance within bulk plants can be a challenge. The P3 team simplified what was previously a complex process. P3's bulk plant system allows propane marketers to efficiently achieve regulatory compliance by providing a mobile inspection service for inspectors and automated compliance reporting for management. Benefits include smarter bulk plant inspections, more efficient reporting, identification of top issues and a convenient reporting dashboard.



## FALLTECH ▶

### Upgraded FT-R SRL

[falltech.com](http://falltech.com)

FallTech has launched its upgraded FT-R Self-Retracting Lifeline (SRL), now supporting up to 420 pounds — a 35% increase in capacity. With advanced internal mechanics and a compact energy absorber, the FT-R combines durability, comfort and enhanced safety in a lightweight, portable design. Compatible with the FallTech AXIS digital calculator for precise fall clearance measurements, the FT-R meets ANSI Class 2 standards and is available in 20-, 30- and 60-foot lengths. This innovative SRL offers protection at a competitive price, ideal for demanding work environments.